

N-Channel Enhancement Mode MOSFET

Feature Description

- 200V/90A $R_{DS(ON)} = 23m\Omega(typ.)@Vgs = 10V$
- 100% Avalanche Tested
- Reliable and Rugged
- Halogen Free and Green Devices Available (RoHS Compliant)

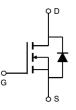
Pin Description



TO-247A-3L

Applications

Power Management for Inverter Systems



N Channel MOSFET

Ordering and Marking Information



Package Code W: TO-247-3L

Date Code YYXXX WW Assembly Material G:Halogen Free Device

Note: HUAYI lead-free products contain molding compounds/die attach materials and 100% matte tin plate Termi-Nation finish; which are fully compliant with RoHS. HUAYI lead-free products meet or exceed the lead-Free requirements of IPC/JEDEC J-STD-020 for MSL classification at lead-free peak reflow temperature. HUAYI defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

HUAYI reserves the right to make changes, corrections, enhancements, modifications, and improvements to this product and/or to this document at any time without notice.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Unit	
Common Rat	tings (Tc=25°C Unless Otherwise Noted)		'	
VDSS	Drain-Source Voltage		200	V
Vgss	Gate-Source Voltage		±20	V
TJ	Maximum Junction Temperature		175	°C
Тѕтс	Storage Temperature Range		-55 to 175	°C
Is	Source Current-Continuous(Body Diode)	Tc=25°C	90	А
Mounted on	Large Heat Sink			1
I DM	Pulsed Drain Current *	Tc=25°C	360	А
	Continuous Danie Coment	Tc=25°C	90	А
lσ	Continuous Drain Current	Tc=100°C	64	А
-	M	Tc=25°C	375	W
Po	Maximum Power Dissipation Tc=100°C		187.5	W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.4	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient **		40	°C/W
Eas	Single Pulsed-Avalanche Energy ***	L=0.5mH	833	mJ

Note: * Repetitive rating; pulse width limited by max. junction temperature.

Electrical Characteristics(Tc =25°C Unless Otherwise Noted)

Complete Bonometers		To al O and little as		HY1920			
Symbol	Parameter Test Conditions		Min	Тур.	Max	Unit	
Static Cha	racteristics						
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V,I _{DS} =25	0μΑ	200	_		V
I Durin to Occurred to the con-	Vps=200V,Vgs=0V		-	-	1	μA	
IDSS	IDSS Drain-to-Source Leakage Current		TJ=55°C	-	-	5	μA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _{DS} =2	250µA	2.0	3.0	4.0	V
Igss	Gate-Source Leakage Current	V _{GS} =±20V,V _{DS} =0V		-	-	±100	nA
RDS(ON)*	Drain-Source On-State Resistance	V _{GS} =10V,I _{DS} =45A			23	25	mΩ
Diode Characteristics							
V _{SD} *	Diode Forward Voltage	I _{SD} =45A,V _{GS} =0V		-	0.85	1.2	V
trr	Reverse Recovery Time	L45A dl/dt-100A/		-	80	-	ns
Qrr	Reverse Recovery Charge	IsD=45A,dIsD/dt=100A/µs		-	160	-	nC

^{**} Surface mounted on FR-4 board.

^{***} Limited by T_Jmax , starting T_J=25°C, L = 0.5mH, VD= 100V, V_Gs =10V.

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Electrical Characteristics (Cont.) (Tc =25°C Unless Otherwise Noted)

Cumbal	Parameter	Toot Conditions		HY1920		
Symbol		Test Conditions	Min	Тур.	Max	Unit
Dynamic	Characteristics					
Rg	Gate Resistance	V_{GS} =0V, V_{DS} =0V, F=1MHz	-	3.4	-	Ω
Ciss	Input Capacitance	V _{GS} =0V,	-	5871	-	
Coss	Output Capacitance	V _{DS} =25V,	-	392	-	pF
Crss	Reverse Transfer Capacitance	Frequency=1.0MHz	-	165	-	
td(ON)	Turn-on Delay Time		-	29	-	
Tr	Turn-on Rise Time	$V_{DD}=100V,R_{G}=4\Omega,$	-	45	-	
td(OFF)	Turn-off Delay Time	IDS=45A,VGS=10V	-	22	-	ns
Tf	Turn-off Fall Time		-	41	-	
Gate Charge Characteristics						
Qg	Total Gate Charge	\/ -400\/ \/ -40\/	-	130	-	
Qgs	Gate-Source Charge	$V_{DS} = 100V, V_{GS} = 10V,$ $I_{D} = 30A$	-	22	-	nC
Qgd	Gate-Drain Charge		-	38	_	

Note: *Pulse test, pulse width ≤ 300 us, duty cycle $\leq 2\%$



Typical Operating Characteristic

Figure 1: Power Dissipation

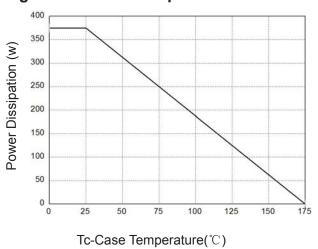


Figure 3: Safe Operation Area

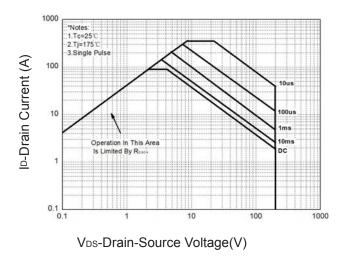


Figure 5: Output Characteristics

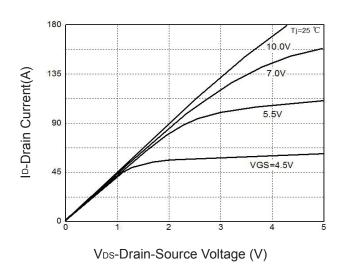


Figure 2: Drain Current

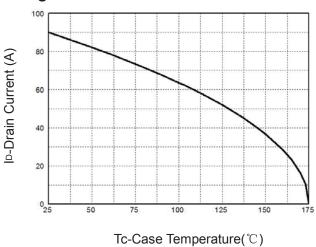
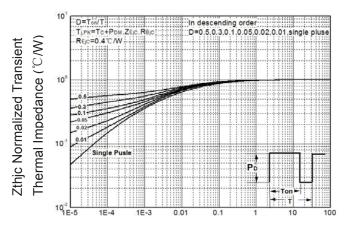
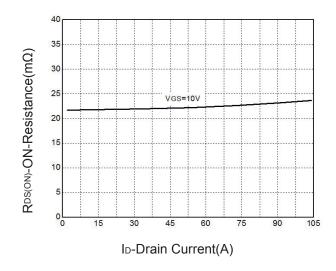


Figure 4: Thermal Transient Impedance



Maximum Effective Transient Thermal Impedance, Junction-to-Case

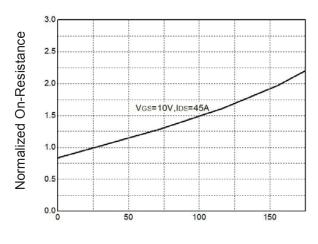
Figure 6: Drain-Source On Resistance





Typical Operating Characteristics(Cont.)

Figure 7: On-Resistance vs. Temperature



Tj-Junction Temperature (°C)

Figure 9: Capacitance Characteristics

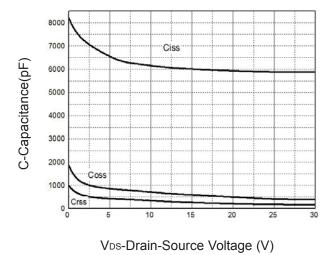
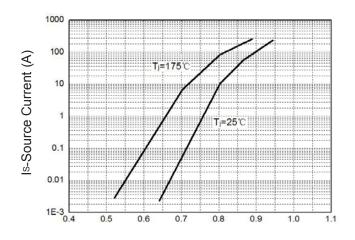
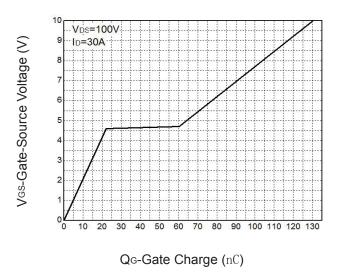


Figure 8: Source-Drain Diode Forward



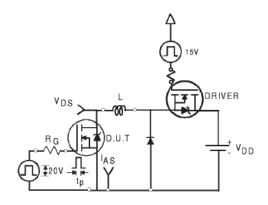
Vsp, Source-Drain Voltage(V)

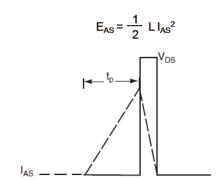
Figure 10: Gate Charge Characteristics



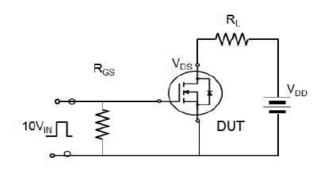


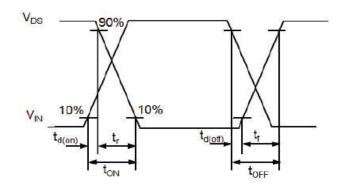
Avalanche Test Circuit



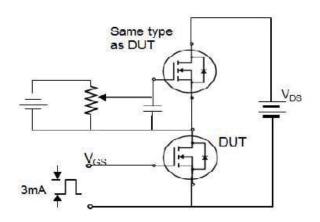


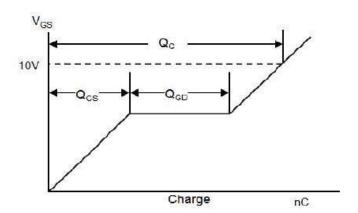
Switching Time Test Circuit





Gate Charge Test Circuit





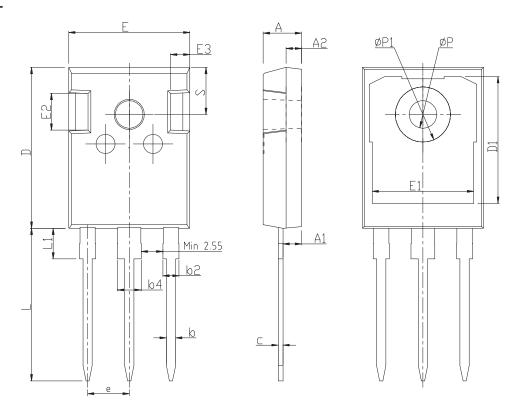


Device Per Unit

Package Ty e	Unit	Quantity
TO-247A-3L	Tube	30

Package Information

TO-247A-3L

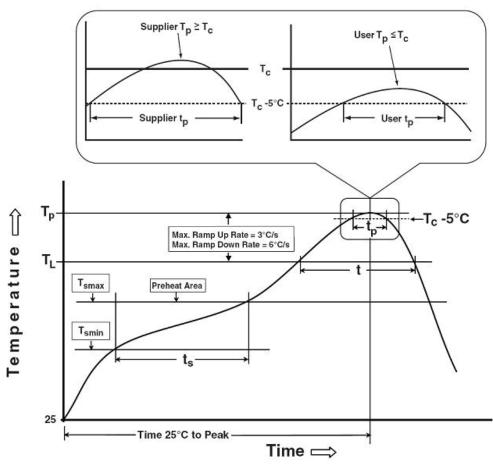


COMMON DIMENSIONS

SYMBOL	mm			
STMDOL	MIN	NOM	MAX	
A	4.80	5.00	5. 20	
A1	2.21	2.41	2.61	
A2	1.85	2.00	2. 15	
b	1.11	1.21	1.36	
b2	1.91	2.01	2.21	
b4	2.91	3.01	3. 21	
С	0.51	0.61	0. 75	
D	20.70	21.00	21.30	
D1	16.25	16.55	16.85	
Е	15.50	15.80	16. 10	
E1	13.00	13.30	13.60	
E2	4.80	5.00	5. 20	
Е3	2.30	2.50	2.70	
е	5. 44BSC			
L	19.62	19.92	20.22	
L1	_	_	4.30	
Р	3.40	3.60	3.80	
P1	_	-	7. 30	
S	6. 15BSC			



Classification Profile



Classification Reflow Profiles

Profile Feature	Sn-Pb Eutectic Assembly	Pb-Free Assembly
Preheat & Soak	100 °C	150 °C
Temperature min (T _{smin})	150 °C	200 °C
Temperature max (T _{smax}) Time (Tsmin to Tsmax) (t _s)	60-120 seconds	60-120 seconds
Average ramp-up rate (T _{smax} to T _P)	3 °C/second max.	3°C/second max.
Liquidous temperature (T _L)	183 °C	217 °C
Time at liquidous (t∟)	60-150 seconds	60-150 seconds
Peak package body Temperature $(T_p)^*$	See Classification Temp in table 1	See Classification Temp in table 2
Time (t _P)** within 5°C of the specified classification temperature (T _c)	20** seconds	30** seconds
Average ramp-down rate (Tpto Tsmax)	6 °C/second max.	6 °C/second max.
Time 25°C to peak temperature	6 minutes max.	8 minutes max.
*Tolorance for peak profile Tomporature	(T) is defined as a supplier minimum	and a user maximum

^{*}Tolerance for peak profile Temperature (Tp) is defined as a supplier minimum and a user maximum.

^{**} Tolerance for time at peak profile temperature (tp) is defined as a supplier minimum and a user maximum.

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Table 1.SnPb Eutectic Process – Classification Temperatures (Tc)

Package	Volume mm³	Volume mm³
Thickness	<350	≥350
<2.5 mm	235 °C	220 °C
≥2.5 mm	220 °C	220 °C

Table 2.Pb-free Process – Classification Temperatures (Tc)

Package	Volume mm ³	Volume mm ³	Volume mm ³
Thickness	<350	350-2000	≥2000
<1.6 mm	260 °C	260 °C	260 °C
1.6 mm – 2.5 mm	260 °C	250 °C	245 °C
≥2.5 mm	250 °C	245 °C	245 °C

Reliability Test Program

Test item	Method	Description
SOLDERABILITY	JESD-22, B102	5 Sec, 245°C
HTRB	JESD-22, A108	168/500/1000 Hrs, Bias @ 150°C
PCT	JESD-22, A102	96 Hrs, 100%RH, 2atm, 121°C
тст	JESD-22, A104	500 Cycles, -55°C~150°C

Customer Service

Worldwide Sales and Service: sales@hymexa.com Technical Support: Technology@hymexa.com

Huayi Microelectronics Co., Ltd.

No.8928, Shangji Road, Economic and Technological Development Zone, Xi'an, China

TEL: (86-029) 86685706 FAX: (86-029) 86685705 E-mail: sales@hymexa.com Web net: www.hymexa.com